

SLD30L03A

N And P-Channel Enhancement Mode MOSFET

General Description

This Power MOSFET is produced using Msemitek's advanced TRENCH technology.

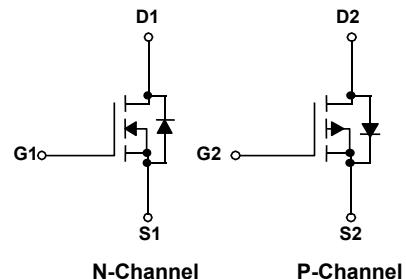
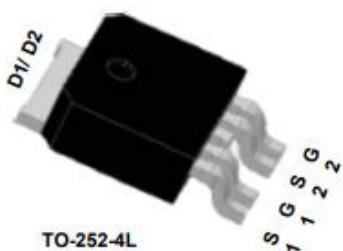
This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

Application

- Battery Protection
- Load Switch
- Power Management

Features

- N-Channel: 30V 25A
 $R_{DS(on)Typ} = 9m\Omega @ V_{GS} = 10V$
 $R_{DS(on)Typ} = 13m\Omega @ V_{GS} = 4.5V$
- P-Channel: -30V- 20A
 $R_{DS(on)Typ} = 23m\Omega @ V_{GS} = -10V$
 $R_{DS(on)Typ} = 34.5m\Omega @ V_{GS} = -4.5V$
- Very Low On-resistance $R_{DS(ON)}$
- Low Crss
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Absolute Maximum Ratings

$T_c = 25^\circ C$ unless otherwise noted

Symbol	Parameter	N-Channel	P-Channel	Units
V_{DSS}	Drain-Source Voltage	30	-30	V
I_D	Drain Current - Continuous ($T_c = 25^\circ C$)	25	-20	A
	- Continuous ($T_c = 100^\circ C$)	14	-13	A
I_{DM}	Drain Current - Pulsed (Note 1)	120	-60	A
V_{GSS}	Gate-Source Voltage	± 20	± 20	V
P_D	Power Dissipation ($T_c = 25^\circ C$)	15.5	27	W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	8	4.6	$^\circ C/W$
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150		$^\circ C$
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300		$^\circ C$

* Drain current limited by maximum junction temperature.

Package Marking

Part Number	Top Marking	Package	Packing Method	MOQ	QTY
SLD30L03A	SLD30L03A	T0-252-4L	Tape	2500	25000

N-Channel Electrical Characteristics

$T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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Off Characteristics

BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 30 \text{ V}, V_{\text{GS}} = 0 \text{ V}$	--	--	1	μA
		$V_{\text{DS}} = 24 \text{ V}, T_C = 125^\circ\text{C}$	--	--	10	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{\text{GS}} = 20 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	$V_{\text{GS}} = -20 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	-100	nA

On Characteristics

$V_{\text{GS(Th)}}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250 \mu\text{A}$	1.0	-	2.0	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}} = 10 \text{ V}, I_D = 15 \text{ A}$	--	9	13	$\text{m}\Omega$
		$V_{\text{GS}} = 4.5 \text{ V}, I_D = 10 \text{ A}$	-	13	20	
g_{FS}	Forward Transconductance	$V_{\text{DS}} = 5 \text{ V}, I_D = 30 \text{ A}$	--	15	--	S

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{\text{DS}} = 15 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1.0 \text{ MHz}$	--	1116	-	pF
C_{oss}	Output Capacitance		--	187	-	pF
C_{rss}	Reverse Transfer Capacitance		--	152	-	pF

Switching Characteristics

$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{GS}} = 10 \text{ V}, V_{\text{DS}} = 15 \text{ V}, R_L = 2.5 \Omega, I_D = 15 \text{ A}$	--	15	--	ns
t_r	Turn-On Rise Time		--	19	--	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	35	--	ns
t_f	Turn-Off Fall Time		--	21	--	ns
Q_g	Total Gate Charge	$V_{\text{DS}} = 15 \text{ V}, I_D = 15 \text{ A}, V_{\text{GS}} = 10 \text{ V}$	--	13.3	--	nC
Q_{gs}	Gate-Source Charge		--	3.1	--	nC
Q_{gd}	Gate-Drain Charge		--	5	--	nC

Drain-Source Diode Characteristics and Maximum Ratings

I_s	Maximum Continuous Drain-Source Diode Forward Current	--	--	30	A
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current	--	--	120	A

Notes:

1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
2. Pulse Test: Pulse Width $\leq 300 \mu\text{s}$, Duty Cycle $\leq 2\%$

P-Channel Electrical Characteristics

$T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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Off Characteristics

BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}, I_D = 250 \mu\text{A}$	-30	--	--	V
$I_{\text{DS}}^{\text{SS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}} = -30 \text{ V}, V_{\text{GS}} = 0 \text{ V}$	--	--	-1	μA
		$V_{\text{DS}} = -24 \text{ V}, T_C = 125^\circ\text{C}$	--	--	-10	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{\text{GS}} = 20 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	$V_{\text{GS}} = -20 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	-100	nA

On Characteristics

$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250 \mu\text{A}$	-1.0	-	-2.2	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}} = -10 \text{ V}, I_D = -10 \text{ A}$	--	23	34	$\text{m}\Omega$
		$V_{\text{GS}} = -4.5 \text{ V}, I_D = -5 \text{ A}$	-	34.5	46	
g_{FS}	Forward Transconductance	$V_{\text{DS}} = -5 \text{ V}, I_D = -20 \text{ A}$	--	18	--	S

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{\text{DS}} = -15 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1.0 \text{ MHz}$	--	2800	-	pF
C_{oss}	Output Capacitance		--	346	-	pF
C_{rss}	Reverse Transfer Capacitance		--	319	-	pF

Switching Characteristics

$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{GS}} = -10 \text{ V}, V_{\text{DS}} = -15 \text{ V}, R_L = 2.3 \Omega, I_D = -20 \text{ A}$	--	14	--	ns
t_r	Turn-On Rise Time		--	20	--	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	95	--	ns
t_f	Turn-Off Fall Time		--	65	--	ns
Q_g	Total Gate Charge	$V_{\text{DS}} = -15 \text{ V}, I_D = -20 \text{ A}, V_{\text{GS}} = -10 \text{ V}$	--	30	--	nC
	Gate-Source Charge		--	5.3	--	nC
	Gate-Drain Charge		--	7.6	--	nC

Drain-Source Diode Characteristics and Maximum Ratings

I_s	Maximum Continuous Drain-Source Diode Forward Current	--	--	-10	A
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current	--	--	-40	A

Notes:

1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
2. Pulse Test: Pulse Width≤300μs, Duty Cycle≤2%

N- Channel Typical Characteristics

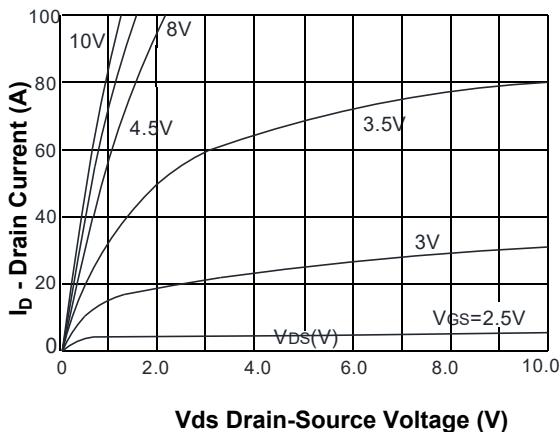


Figure 1. On-Region Characteristics

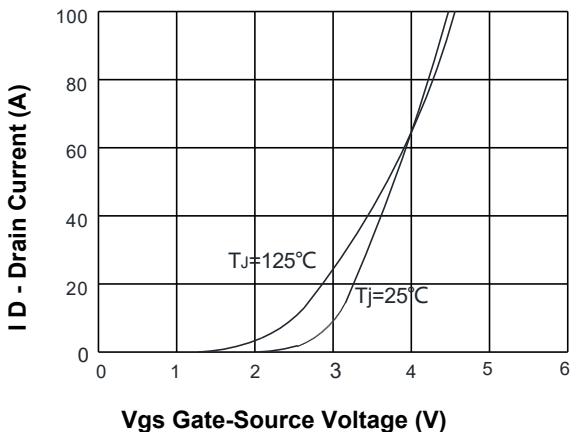


Figure 2. Transfer Characteristics

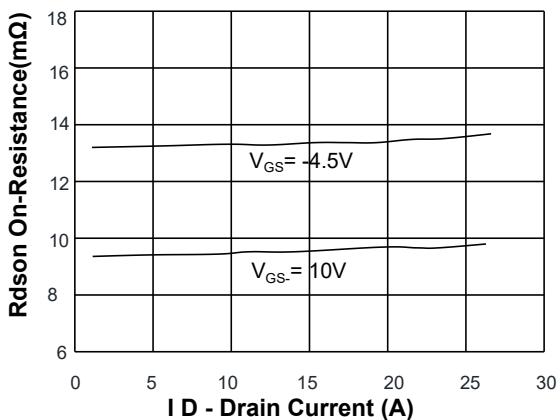


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

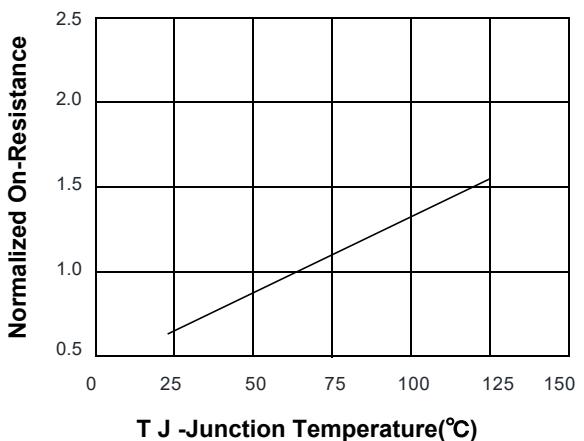


Figure 4. On-Resistance Variation vs Temperature

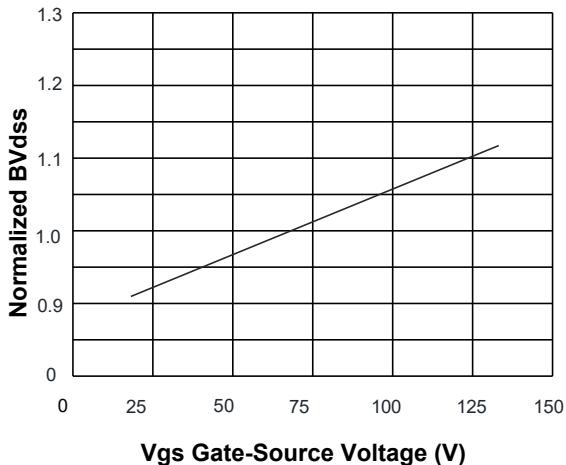


Figure 5. On-Resistance Variation vs Temperature

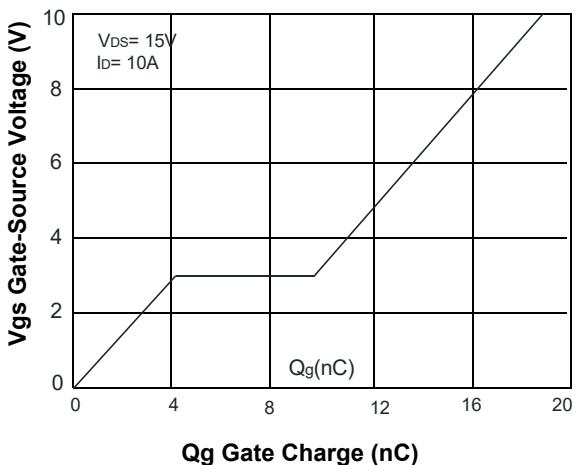


Figure 6. Gate Charge Characteristics

N-Channel Typical Characteristics (Continued)

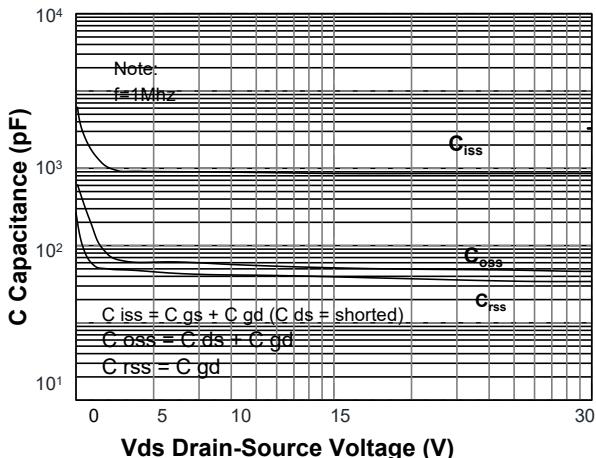


Figure 7. Capacitance vs Vds

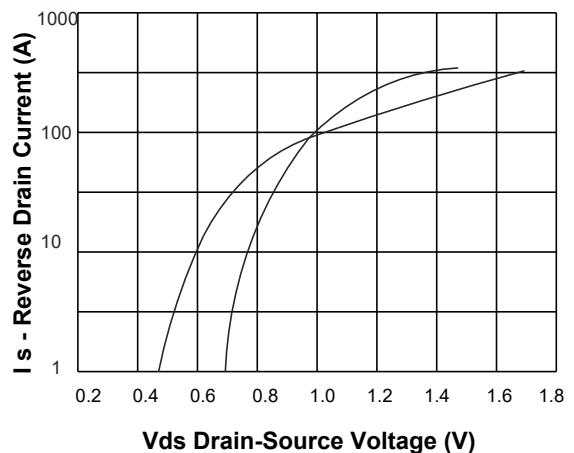


Figure 8. Reverse Drain Current vs Temperature

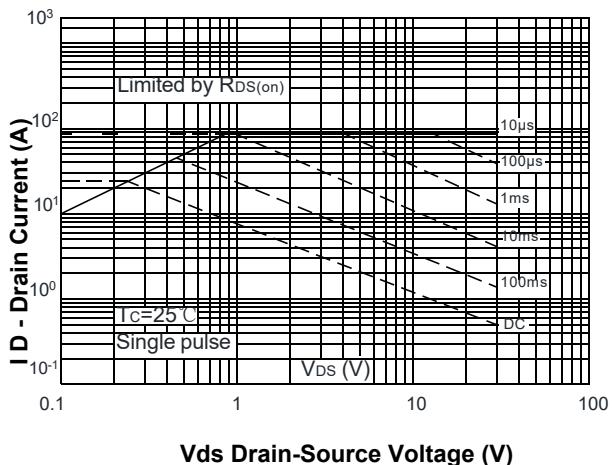


Figure 9. Maximum Safe Operating Area

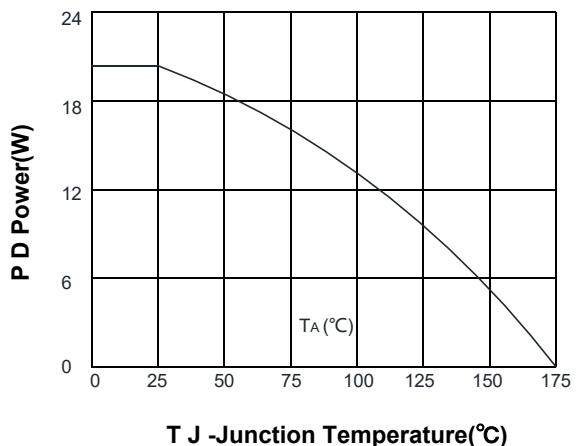


Figure 10. Maximum Power Dissipation vs Case Temperature

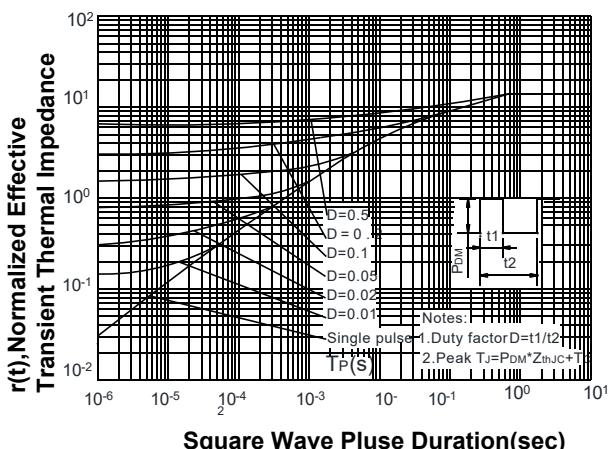


Figure 11. Transient Thermal Response Curve

P- Channel Typical Characteristics

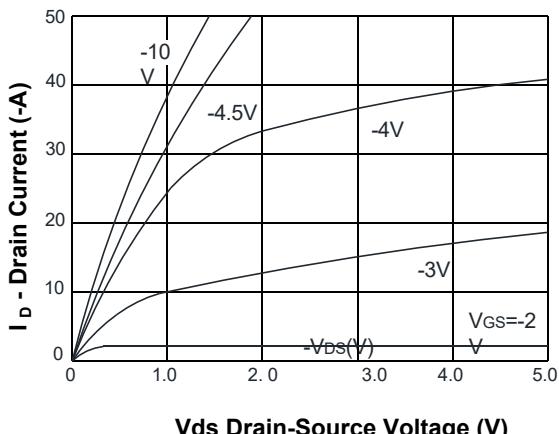


Figure 1. On-Region Characteristics

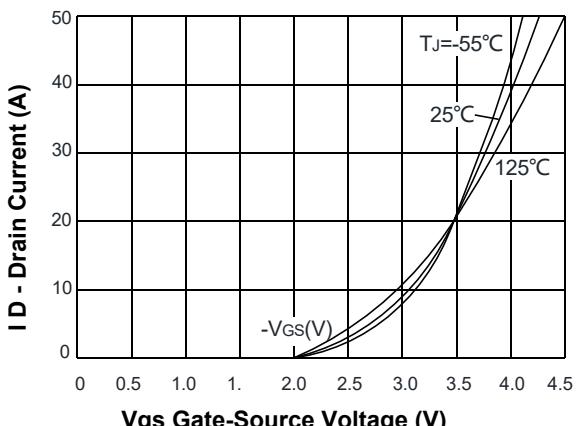


Figure 2. Transfer Characteristics

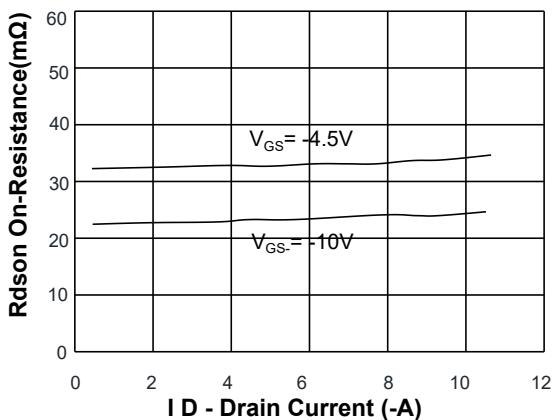


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

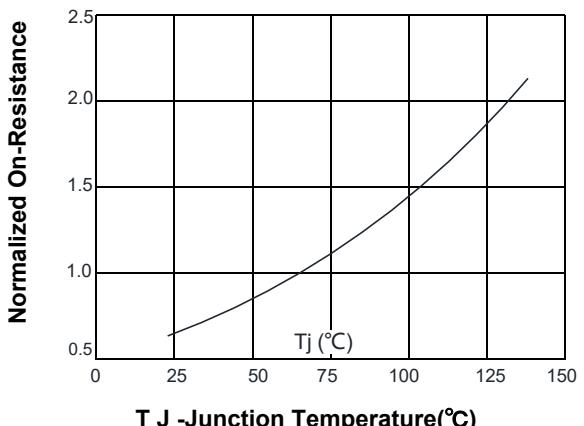


Figure 4. On-Resistance Variation vs Temperature

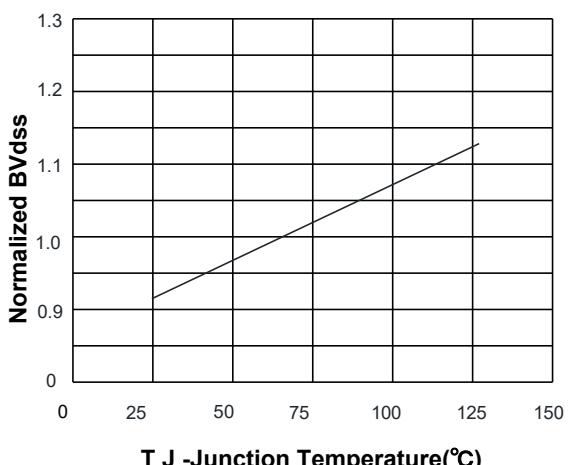


Figure 5. BV DSS vs Junction Temperature

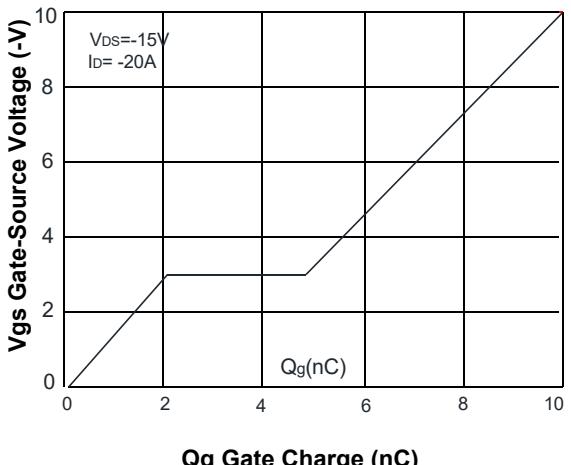


Figure 6. Gate Charge Characteristics

P- Channel Typical Characteristics (Continued)

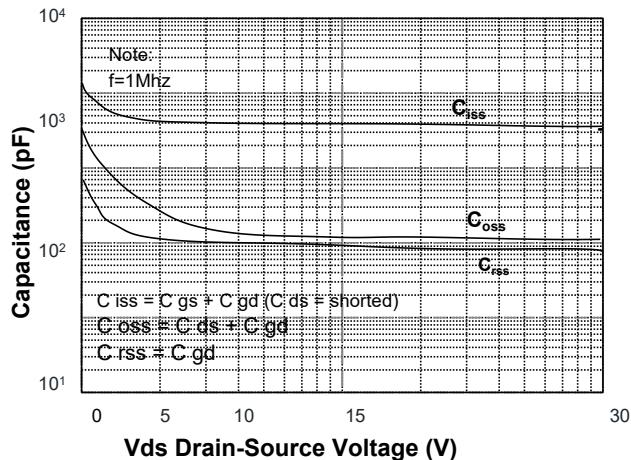


Figure 7. Capacitance vs Vds

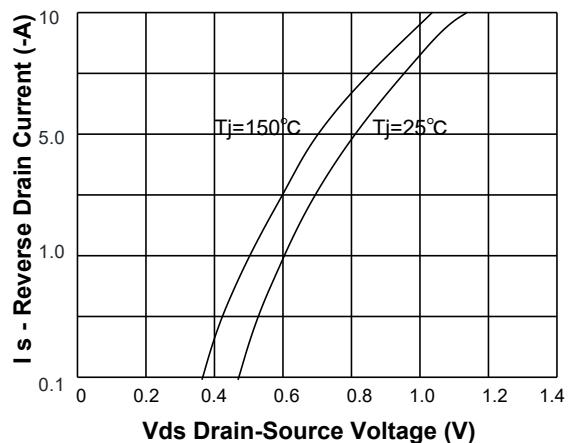


Figure 8. Reverse Drain Current vs Temperature

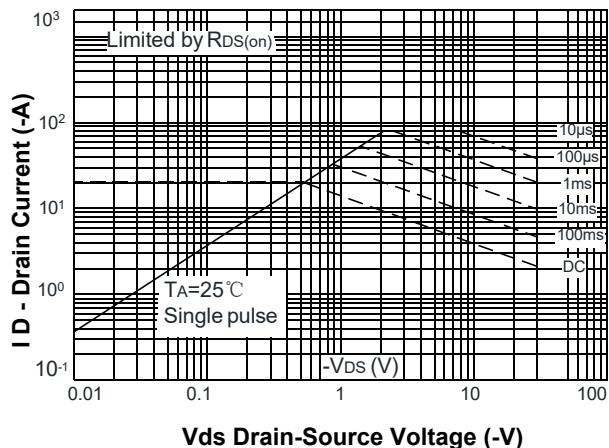


Figure 9. Maximum Safe Operating Area

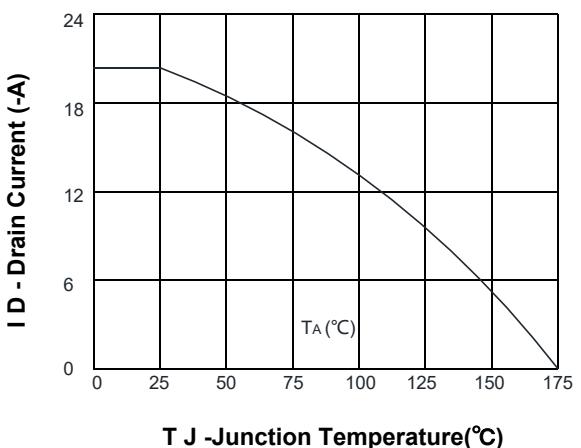


Figure 10. maximum Drain Current vs Case Temperature

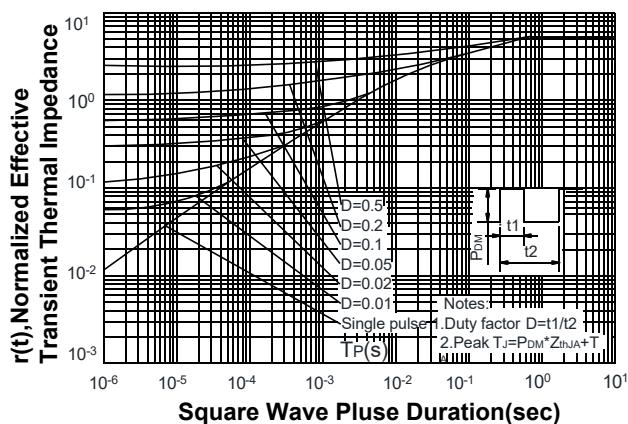
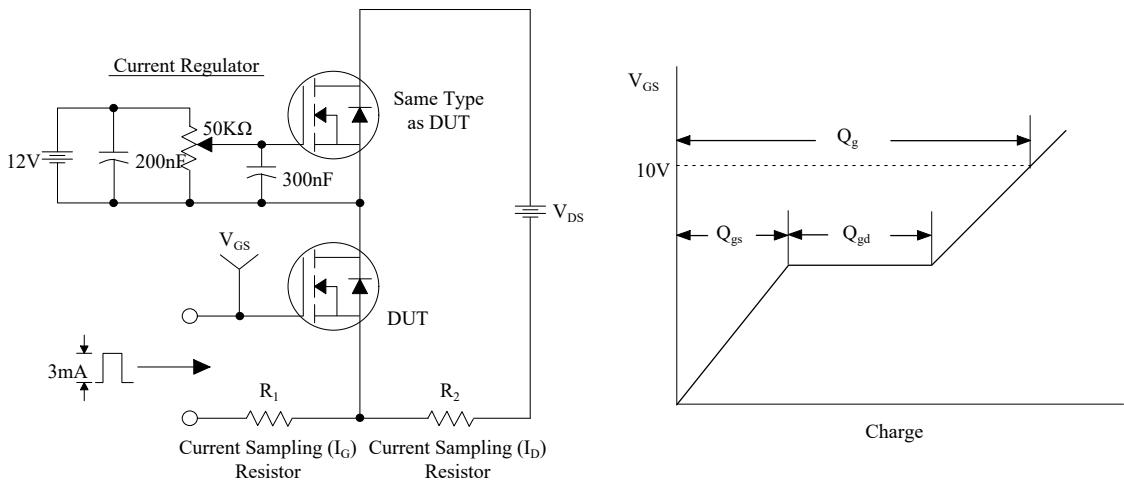
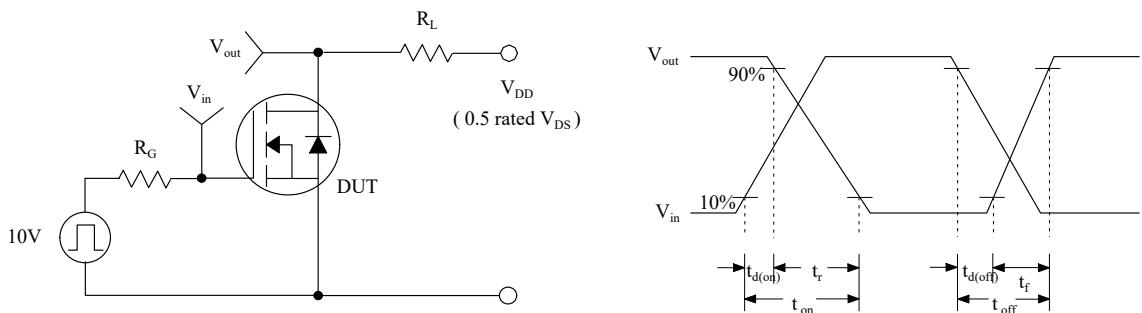


Figure 11. Transient Thermal Response Curve

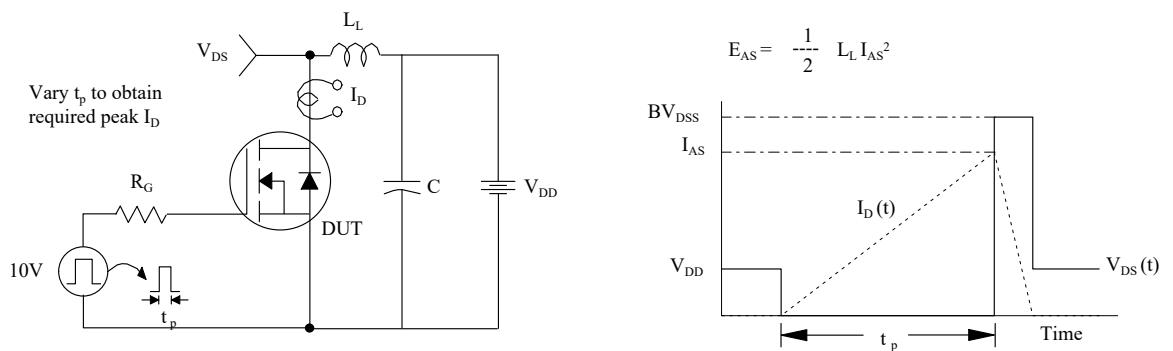
Gate Charge Test Circuit & Waveform



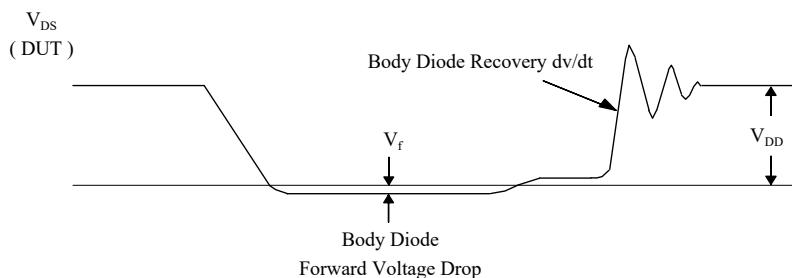
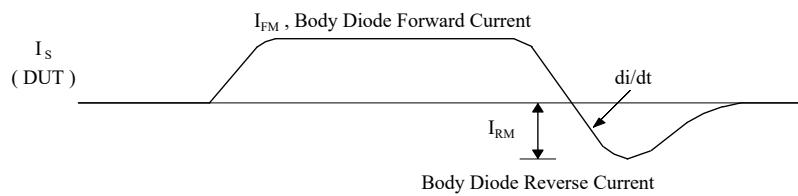
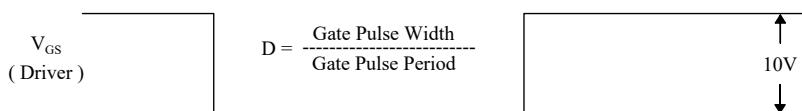
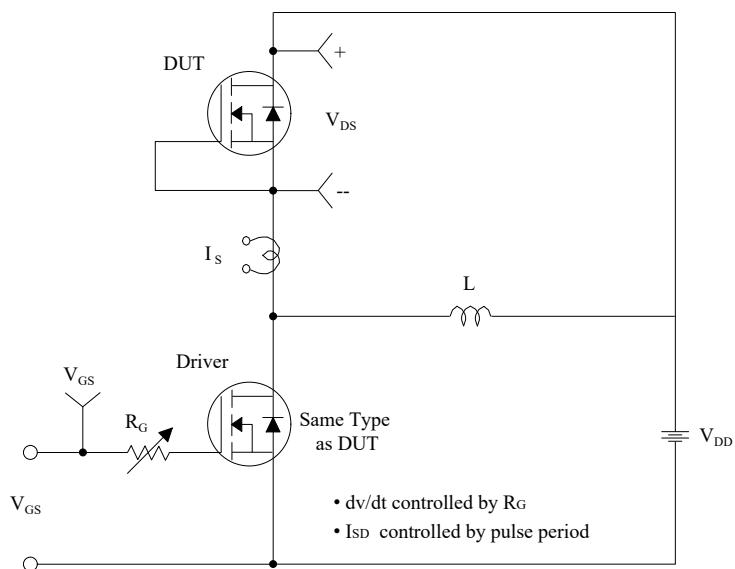
Resistive Switching Test Circuit & Waveforms



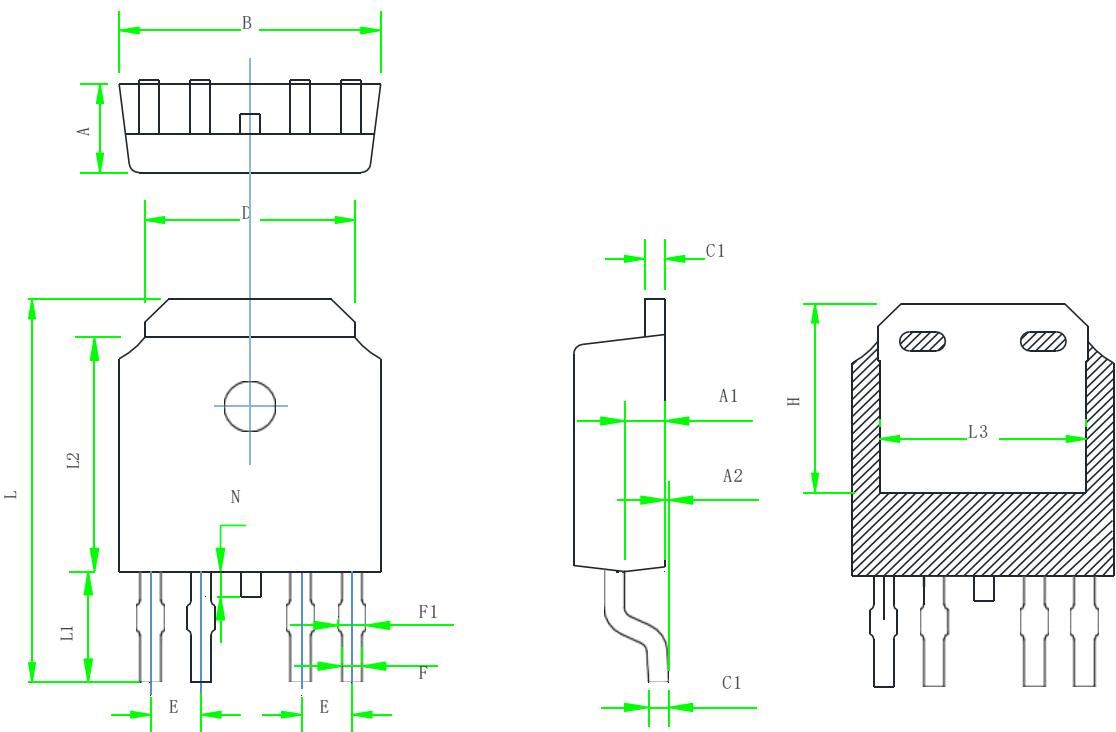
Unclamped Inductive Switching Test Circuit & Waveforms



Peak Diode Recovery dv/dt Test Circuit & Waveforms



TO-252 -4L OUTLINE



SYMBOL	Mechanical Dimensions/mm			SYMBOL	Mechanical Dimensions/mm		
	MIN	NOM	MAX		MIN	NOM	MAX
A	2.10	2.30	2.45	E	-	1.27type	-
A1	0.85	1.01	1.15	F1	0.40	0.60	0.80
A2	0.05	0.15	0.25	F	0.38	0.50	0.65
B	6.35	6.60	6.80	H	4.55	4.90	5.25
C	0.40	0.50	0.60	L	9.60	10.00	10.30
C1	0.40	0.50	0.60	L1	2.50	2.80	3.10
D	5.05	5.32	5.55	L2	5.85	6.10	6.35
N	0.40	0.65	0.90	L3	4.85	5.20	5.55

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